

# Laser-induced fluorescence and Langmuir probe determination of $\text{Cl}_2^+$ and $\text{Cl}^+$ absolute densities in transformer-coupled chlorine plasmas

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Laser induced fluorescence detection of  $\text{Cl}_2^+$  has been used to track their relative concentration in a high-density inductively (transformer) coupled (TCP) 10 mTorr chlorine plasma as a function of the 13.56 MHz radio frequency (rf) power. This relative  $\text{Cl}_2^+$  number density was compared to the total absolute positive ion density ( $n_i^+ = n_{\text{Cl}^+} + n_{\text{Cl}_2^+}$ ) obtained with a Langmuir probe. Both  $n_{\text{Cl}_2^+}$  and  $n_i^+$  doubled with increasing rf power from 8 to  $\sim 55$  W in the capacitively coupled (dim) mode. Above the transition from a capacitively to inductively coupled (bright-mode) plasma at  $\sim 85 \pm 35$  W,  $n_{\text{Cl}_2^+}$  decayed with rf power while  $n_i^+$  continued to increase. Consequently,  $\text{Cl}_2^+$  is the dominant ion in dim-mode operation and  $\text{Cl}^+$  is the dominant ion in bright-mode operation, at  $n_i^+ \geq 6 \times 10^{10} \text{ cm}^{-3}$ . With the plasma operating in the reaction ion etch (RIE) mode (the stage powered at 14.56 MHz, and no TCP power)  $n_{\text{Cl}_2^+}$  tracked  $n_i^+$  over the entire range of powers (2–150 W). Thus,  $\text{Cl}_2^+$  is the dominant ion during capacitively coupled RIE operation. © 1999 American Institute of Physics. [S0003-6951(99)03612-8]

$\text{Cl}_2$ -containing plasmas are widely used to etch of silicon, aluminum and other materials used in silicon-based integrated circuits. Etch rates and the shapes of etched profiles depend on the relative fluxes of  $\text{Cl}_2$ ,  $\text{Cl}$ ,  $\text{Cl}_2^+$  and  $\text{Cl}^+$ . Previously, we have reported measurements of  $\text{Cl}$  and  $\text{Cl}_2$  number densities during slow etching [i.e., with an oxidized Si wafer, or with a Si wafer with no radio frequency (rf) bias to the stage] in a 10 mTorr chlorine, transformer-coupled plasma (TCP).<sup>1</sup> Under these conditions, the predominant neutral species at low TCP rf power is  $\text{Cl}_2$ , as expected. As rf power is increased, however,  $\text{Cl}$  radicals account for  $\sim 90\%$  of all neutrals at a power density of  $0.4 \text{ W/cm}^3$ . The transition from a  $\text{Cl}_2$  to  $\text{Cl}$ -dominated plasma is smooth, with almost no  $\text{Cl}_2$  dissociated in the capacitive mode (up to  $\sim 80$  W), and a gradual increase in percent dissociation with increasing power in the inductive mode. Similar trends were observed in other laboratory and commercial plasma reactors with sharper transitions at lower pressure.<sup>2–4</sup>

Fractional densities of  $\text{Cl}^+$  and  $\text{Cl}_2^+$  influence both plasma steady state conditions (through ion diffusion and losses) and plasma-surface interactions during etching (through ion bombardment). However, there still remains uncertainty about the relative concentrations of  $\text{Cl}^+$  and  $\text{Cl}_2^+$  throughout these rf power regimes.<sup>5,6</sup> Clarification of the relative abundance of these two ions in a 10 mTorr  $\text{Cl}_2$  plasma as a function of rf power is the objective of this letter.  $\text{Cl}_2^+$  ion density,  $n_{\text{Cl}_2^+}$ , is obtained by calibrating the measured laser-induced fluorescence (LIF) signal.  $n_{\text{Cl}^+}$  is de-

duced from  $n_{\text{Cl}_2^+}$  and the total, absolute positive ion density  $n_i^+ (= n_{\text{Cl}_2^+} + n_{\text{Cl}^+})$  is obtained via Langmuir probe analysis. With no rf bias power, the Si etching rate in this system is  $< 50 \text{ Å/min}$ , presumably due to the low ( $\sim 12$  V) sheath potential, and possibly suppression of etching by sputter transport of quartz from the TCP window. This slow etching rate, verified by the lack of any detectable emission from  $\text{SiCl}_2$  or  $\text{SiCl}_3$ , corresponds to an etching product concentration of  $< 0.1\%$  of the 80 sccm  $\text{Cl}_2$  flow rate. Consequently, we can safely assume that all other ions (i.e.,  $\text{SiCl}_x^+$ ) will be at much lower concentrations than either  $\text{Cl}^+$  or  $\text{Cl}_2^+$ .

The reactor consists of a stainless steel cylindrical chamber of 36 cm inner diameter and 22 cm height. The top opening of the cylinder is covered by a 25 cm diameter quartz window. Above the window is a TCP source, consisting of a 6 in. diameter, six-loop coil antenna and matching network (LAM Research). The antenna was powered by a 3 kW Plasma-Therm generator operating at 13.56 MHz. An He-cooled chuck, equipped to hold 5 in. wafers, can be moved vertically with respect to the reactor. In these experiments, the chuck was  $\sim 12$  cm from the quartz window. In the TCP mode, no rf power was applied to the stage. In the RIE mode, no power was applied to the TCP coil, and rf power was applied to the chuck at 14.56 MHz. Two quartz windows on opposite sides of the chamber allowed the laser light to pass through the plasma. For Langmuir probe measurements, one of the windows was replaced by a flange that mated to the probe.

The LIF apparatus consisted of an excimer laser-pumped dye laser and spectrometer. A Lambda Physik model EMG 201 XeCl excimer laser (10 Hz repetition rate, 3080 Å, 20 ns pulse length, 150 mJ pulse energy) pumped a Lambda

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Physik model FL2002 dye laser (nominal output of 3.5 mJ/pulse at 3876 Å, using BiBuO dye, dissolved in cyclohexane) tuned to excite fluorescence in  $\text{Cl}_2^+$ . LIF and plasma-induced emission (PIE) were observed through quartz window, normal to the laser beam, and were imaged with a lens onto the entrance slit of a 0.25 m focal length monochromator (MacPherson model 218) equipped with a GaAs photomultiplier tube (PMT). The monochromator was set to pass 3960 Å fluorescence with a band width of 10 Å set by the 400  $\mu\text{m}$  wide slits. The PMT output was directed to a two-channel boxcar integrator (model SR 280). One channel monitored the transient LIF signal plus the PIE background at 3960 Å. The second channel monitored the PIE signal delayed by 10  $\mu\text{s}$ , allowing the  $<1$   $\mu\text{s}$  LIF signal [mostly determined by the resistance-capacitance (RC) time constant of the detection system] to decay to a negligible level. The LIF intensity was measured as a function of rf power for a 10 mTorr  $\text{Cl}_2$  plasma, and additionally as a function of laser pulse energy (0.38–1.28 mJ) to assess the effect of drift in laser power during the rf power dependence measurements. The transmitted laser pulse energy was varied within the above range by placing a combination of quartz flats in front of the beam.

Positive ion density was measured by a Scientific Systems Langmuir probe. Values were obtained from a fit of the ion current part of current–voltage characteristics by the Laframboise model.<sup>7</sup> The effective ion mass was initially assumed to be 48 amu (corresponding to the 50/50 fraction of  $\text{Cl}^+$  and  $\text{Cl}_2^+$  ions),<sup>7</sup> and was then corrected using the LIF data to obtain self-consistent results. The effective ion mass is 70 amu for lower power (for  $\sim 100\%$   $\text{Cl}_2^+$ ) and 35 amu for high power (for  $\sim 100\%$   $\text{Cl}^+$ ), with intermediate values consistent with the  $[\text{Cl}^+]/[\text{Cl}_2^+]$  ratio.

Laser radiation in the range of 3860–3890 Å excites  $\text{Cl}_2^+$  ions from the  $v''=0$  vibrational level of the  $X^2\Pi_i$  ground electronic state to the  $n'=10$  “vibrational level”<sup>8</sup> of the  $A^2\Pi_i$  excited state.<sup>9,10</sup> Excited ions fluoresce at wavelengths longer than or equal to the laser wavelength, corresponding to transitions from  $n'=10$  to  $v''$  levels of the ground state. To determine the most suitable laser wavelength for excitation, a fluorescence excitation spectrum was obtained by scanning the laser wavelength from 3860 to 3890 Å, with the bandpass of the monochromator at 3960 Å to capture the  $n'=10 \rightarrow v''=1$  emission. This redshifted vibronic band was chosen to avoid scatter light from the laser. This spectrum is shown in Fig. 1 for the 10 mTorr  $\text{Cl}_2$  plasma at 165 W TCP power. Figure 1 reveals that an excitation wavelength of 3876.4 Å produces roughly a maximal LIF signal at 3960 Å. This corresponds to excitation to the  $J'=30.5$  (*R* branch) and 27.5 (*P* branch) rotational levels, within an uncertainty of  $\pm 1$ . The laser and monochromator wavelengths were fixed at these values in the experiments described below.

Three sets of LIF measurements were made as a function of TCP power. During each set, the laser power started at  $\sim 1.5$ –3 mJ and decayed by  $\sim 40\%$  by the end of the run. Measurements were done in random order of TCP power to eliminate any systematic error. Nonetheless, a dependence of the LIF signal on laser pulse energy (Fig. 2) at constant TCP power (200 W) was performed to assess the validity of ignoring the degradation in laser pulse energy. The LIF inten-

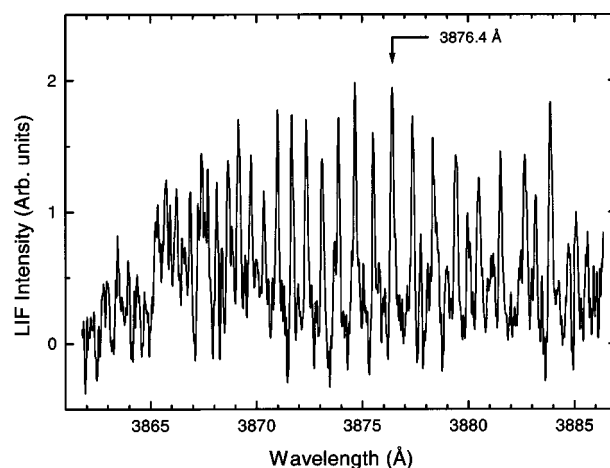


FIG. 1. Fluorescence excitation spectrum of  $\text{Cl}_2^+$  in a 10 mTorr  $\text{Cl}_2$  plasma at 165 W TCP power. The peak labeled 3876.4 Å is the transition corresponding to excitation to  $J'=30.5 \pm 1$  (*R* branch) and  $27.5 \pm 1$  (*P* branch).

sity showed a moderately saturated, linear dependence on the laser pulse energy, over a range of pulse energies wider and somewhat lower than that encountered in each set of experiments. Even higher laser energies would result in a greater degree of saturation. Consequently, ignoring the decay in laser power introduced a negligible ( $\pm 7\%$ ) scatter in the LIF signal versus TCP power. The three sets of measurements were normalized at a common TCP power to account for long term drifts in optical alignment, laser wavelength, and detector sensitivity.

$n_{\text{Cl}^+}$  and  $n_{\text{Cl}_2^+}$  are shown in Fig. 3 as a function of power for (a) TCP and (b) RIE plasmas with 10 mTorr  $\text{Cl}_2$ . At low TCP powers (8–40 W) in the dim, capacitive mode,  $n_{\text{Cl}_2^+}$  follows  $n_i^+$ . This suggests that  $n_{\text{Cl}_2^+}$  is the dominant ion at lower power (see below), consistent with the fact that the gas phase is overwhelmingly  $\text{Cl}_2$ .<sup>1</sup> We therefore calibrated the LIF measurements by normalizing  $n_{\text{Cl}_2^+}$  to  $n_i^+$  from 8 to 40 W. Above  $\sim 100$  W, the TCP plasma enters the inductive mode, and  $n_i^+$  increases more strongly with power, as expected. In contrast,  $n_{\text{Cl}_2^+}$  decreases by a factor of  $\sim 10$  as TCP

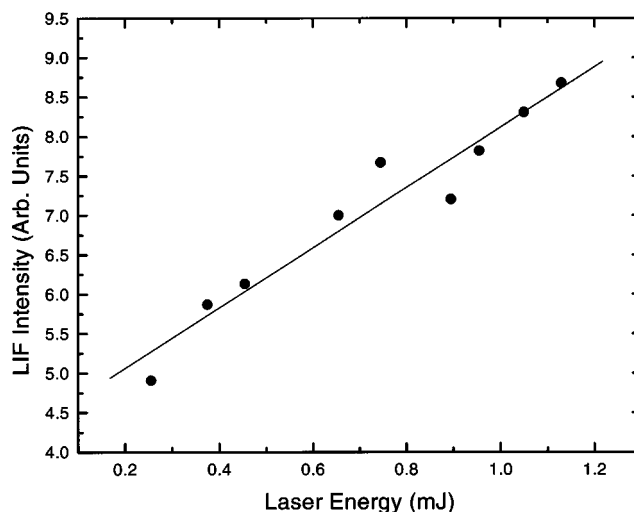


FIG. 2. LIF intensity of  $\text{Cl}_2^+$  vs laser pulse energy in a 10 mTorr  $\text{Cl}_2$  TCP plasma at 200 W.

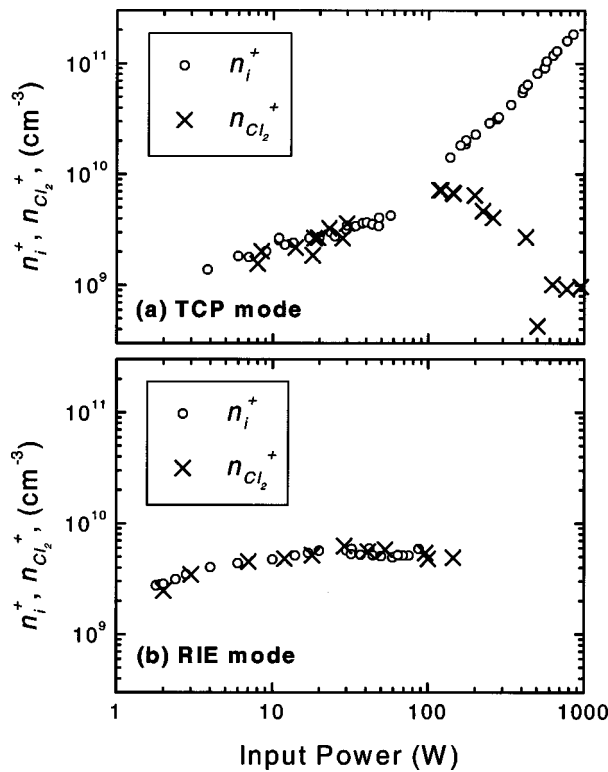


FIG. 3.  $n_{\text{Cl}_2^+}$  (measured by LIF) and  $n_i^+$  (measured with a Langmuir probe) vs power in 10 mTorr  $\text{Cl}_2$  plasmas: (a) TCP and (b) RIE.

power increases from  $\sim 150$  to 1000 W. At 300 W,  $n_i^+$  ( $=n_{\text{Cl}^+}+n_{\text{Cl}_2^+}$ ) is an order of magnitude larger than  $n_{\text{Cl}_2^+}$ , so  $n_{\text{Cl}^+}/n_{\text{Cl}_2^+} \approx 10$ ; at this same power  $n_{\text{Cl}}/n_{\text{Cl}_2} \sim 1$ .<sup>1</sup> At 1000 W,  $n_{\text{Cl}^+}/n_{\text{Cl}_2^+} \approx 200$ , while  $n_{\text{Cl}}/n_{\text{Cl}_2} \approx 20$ .

The capacitively coupled RIE plasma behaves similarly to the TCP, dim-mode plasma.  $n_{\text{Cl}_2^+}$  (normalized to  $n_i^+$  at  $\sim 3$  W) tracks  $n_i^+$  to the highest attainable power (130 W). Note that the LIF and the Langmuir probe data were both collected from the same region, close ( $\sim 1$  cm) to the chuck and far ( $\sim 12$  cm) from the TCP coil. This could explain the fact that at low powers the plasma density in the RIE mode is higher than that for the TCP mode, which is also capacitively coupled in this low power regime.

As noted above, we assume that there are relatively few  $\text{Cl}^+$  ions at low TCP powers in the capacitive mode. In this regime, dissociation of  $\text{Cl}_2$  is typically a few percent for a 10 mTorr  $\text{Cl}_2$  plasma.<sup>1-4</sup> Ions are produced by the ionization of neutral according to reactions (1)–(3):



The rate of reaction (3) is much less than the comparable rates of reactions (1) and (2),<sup>11</sup> while the loss rates of  $\text{Cl}^+$  and  $\text{Cl}_2^+$  (mainly to the walls) are about equal. Therefore, because  $n_{\text{Cl}}/n_{\text{Cl}_2} \ll 1$  at TCP powers of  $< 40$  W, the dominant ion should be  $\text{Cl}_2^+$ , and our procedure for the calibration of the LIF signal to derive absolute  $n_{\text{Cl}_2^+}$  densities is justified.

In the RIE case, the close match of the two curves indicates that the dominant positive ion remains  $\text{Cl}_2^+$  even at the

highest powers. The plasma volume in this case is small, and the dissociation of  $\text{Cl}_2$  is inefficient at such a low plasma density. Therefore, we expect the gas phase to be mostly  $\text{Cl}_2$  and the dominant ion to be  $\text{Cl}_2^+$  [according to reaction rates (1)–(3)], as for the TCP in the dim mode.

The normalized LIF signals plotted in Fig. 3 are actually proportional to the population of the rovibrational level probed by the laser, not the sum of all populated rotational and vibrational levels. The  $\text{Cl}_2^+$  number densities in Fig. 3 are thus uncorrected for changes in the population of the rotational and vibrational levels probed by the laser. The population of rotation level  $J''=29$  (the average of the two levels monitored: 28.5 and 29.5) is proportional to  $(2J''+1) \times (B''/kT) \exp[-B''J''(J''+1)/kT]$ , where  $B''$  is the ground state rotational constant ( $0.2686 \text{ cm}^{-1}$ ).<sup>9</sup> If the gas temperature  $T$  (assumed to be equilibrated with the  $\text{Cl}_2^+$  rotational temperature) were to increase from 330 to 1000 K (likely an overestimate) over the power range from 40 to 1000 W in Fig. 3(a), then the relative population of  $J''=29$  would fall from 1.0 at 330 K to 0.65 at 1000 K, from rotational heating alone. Similarly, vibrational heating due to the same increase in gas temperature would cause the relative population of the  $v''=0$  level probed by the laser to drop from 1.0 to 0.67.<sup>7</sup> Consequently, no more than a factor of  $\sim 2.3$  of the tenfold decrease in  $n_{\text{Cl}_2^+}$  from 150 to 1000 W TCP power can be attributed to rotational and vibrational heating of  $\text{Cl}_2^+$ .

In conclusion, we have shown that the dominant positive ion in a 10 mTorr  $\text{Cl}_2$  TCP plasma is  $\text{Cl}_2^+$  in dim-mode operation (rf power  $< 85 \pm 35$  W) and  $\text{Cl}^+$  in bright-mode operation ( $\geq 100$  W). At the highest TCP powers investigated,  $n_{\text{Cl}^+}/n_{\text{Cl}_2^+} = 200$  if the effects of heating on the LIF signal are ignored and  $\sim 90$  if the upper limits of such effects are included. For an RIE  $\text{Cl}_2$  plasma,  $\text{Cl}_2^+$  is always dominant, up to the highest power investigated (150 W). Measurements at other pressures (1–20 mTorr  $\text{Cl}_2$ ) in the TCP reactor suggest that the relative densities of  $\text{Cl}^+$  and  $\text{Cl}_2^+$  are fairly pressure independent, with power dependencies similar to that reported here for 10 mTorr.

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<sup>1</sup>V. M. Donnelly, M. V. Malyshev, A. Kornblit, N. A. Ciampa, J. I. Colonnelli, and J. T. C. Lee, *Jpn. J. Appl. Phys.*, Part 1 **37**, 2388 (1998).

<sup>2</sup>M. V. Malyshev, V. M. Donnelly, A. Kornblit, and N. A. Ciampa, *J. Appl. Phys.* **84**, 137 (1998).

<sup>3</sup>M. V. Malyshev, V. M. Donnelly, and S. Samukawa, *J. Appl. Phys.* **84**, 1222 (1998).

<sup>4</sup>J. Y. Choe, L. P. Herman, and V. M. Donnelly, *J. Vac. Sci. Technol. A* **15**, 3024 (1997).

<sup>5</sup>R. S. Wise, D. P. Lymberopoulos, and D. J. Economou, *IEEE Trans. Plasma Sci.* **23**, 73 (1995).

<sup>6</sup>E. Meeks and J. W. Shon, *IEEE Trans. Plasma Sci.* **23**, 4 (1995).

<sup>7</sup>J. G. Laframboise, University of Toronto, Aerospace Report No. 100 (1966).

<sup>8</sup>The excited state vibrational levels  $v'$  were not assigned in Ref. 9. Instead, relative vibrational quantum numbers  $n'$  were reported.

<sup>9</sup>F. P. Huberman, *J. Mol. Spectrosc.* **20**, 29 (1966).

<sup>10</sup>V. M. Donnelly, D. L. Flamm, and G. Collins, *J. Vac. Sci. Technol.* **21**, 817 (1982).

<sup>11</sup>M. V. Kurepa and D. S. Belie, *J. Phys. B* **11**, 3719 (1978).